



Agilent PNA Microwave Network Analyzers

PNA-X Network Analyzers:

N5241/2/4/5/7A

10 MHz to 13.5, 26.5, 43.5, 50, or 67 GHz

PNA Network Analyzers:

E8361/2/3/4C

10 MHz to 20, 40, 50, or 67 GHz

N5250C

10 MHz to 110 GHz

PNA-L Network Analyzers:

N5230C

300 kHz to 6, 13.5, or 20 GHz

10 MHz to 20, 40, or 50 GHz

***The standard in microwave
network analysis***



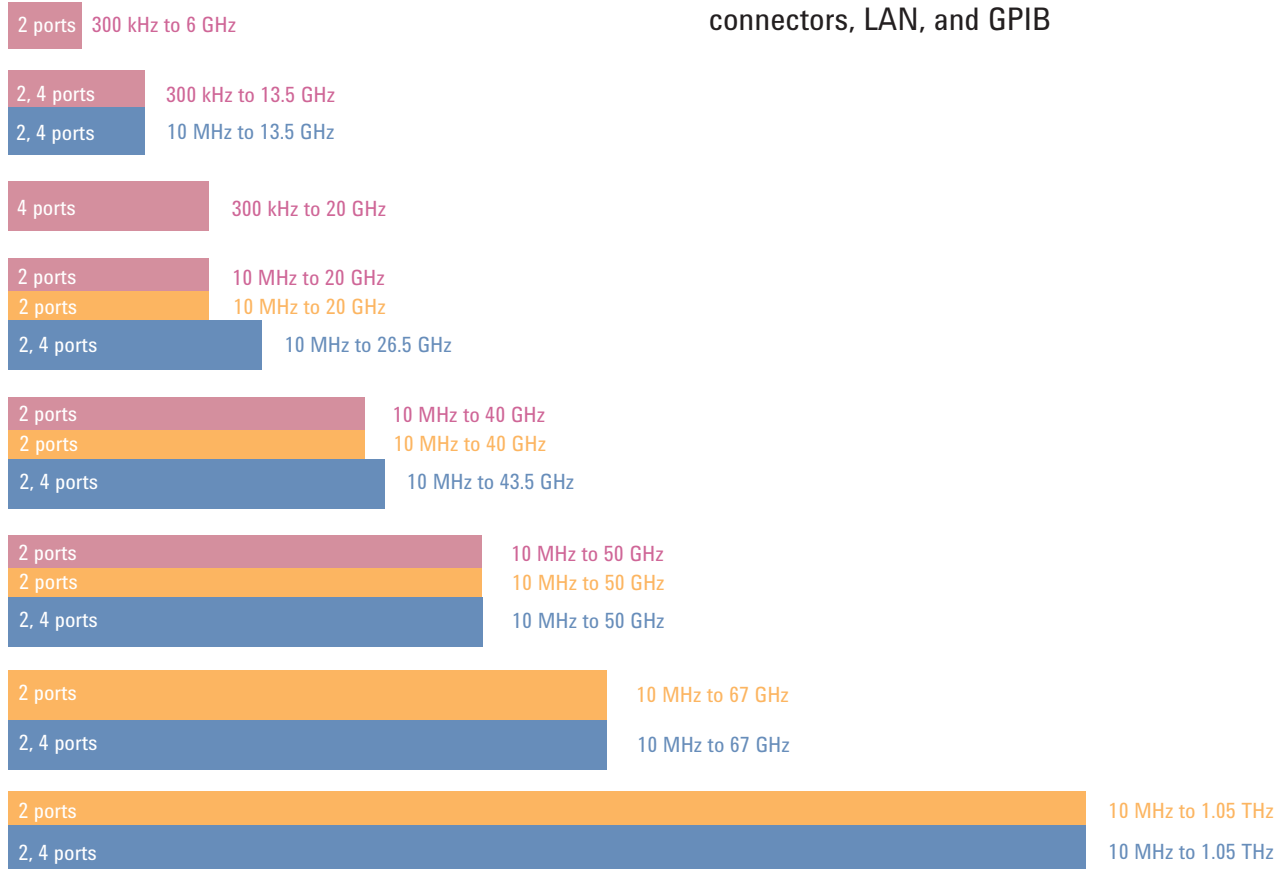
Agilent Technologies

Welcome to the world of PNAs – The most popular microwave network analyzers

The PNA family builds on Agilent’s 40-year legacy of excellence to deliver new standards in speed, accuracy, and versatility for microwave network analysis. The PNA’s architecture includes high quality, stable hardware and flexible software. The standard PNA is suitable for testing passive and active devices such as filters and amplifiers. Users can easily add options to test mixers, harmonics, intermodulation distortion (IMD), pulsed-RF, antennas and millimeter-wave (mmwave) components.

PNA Family

PNA-X PNA PNA-L

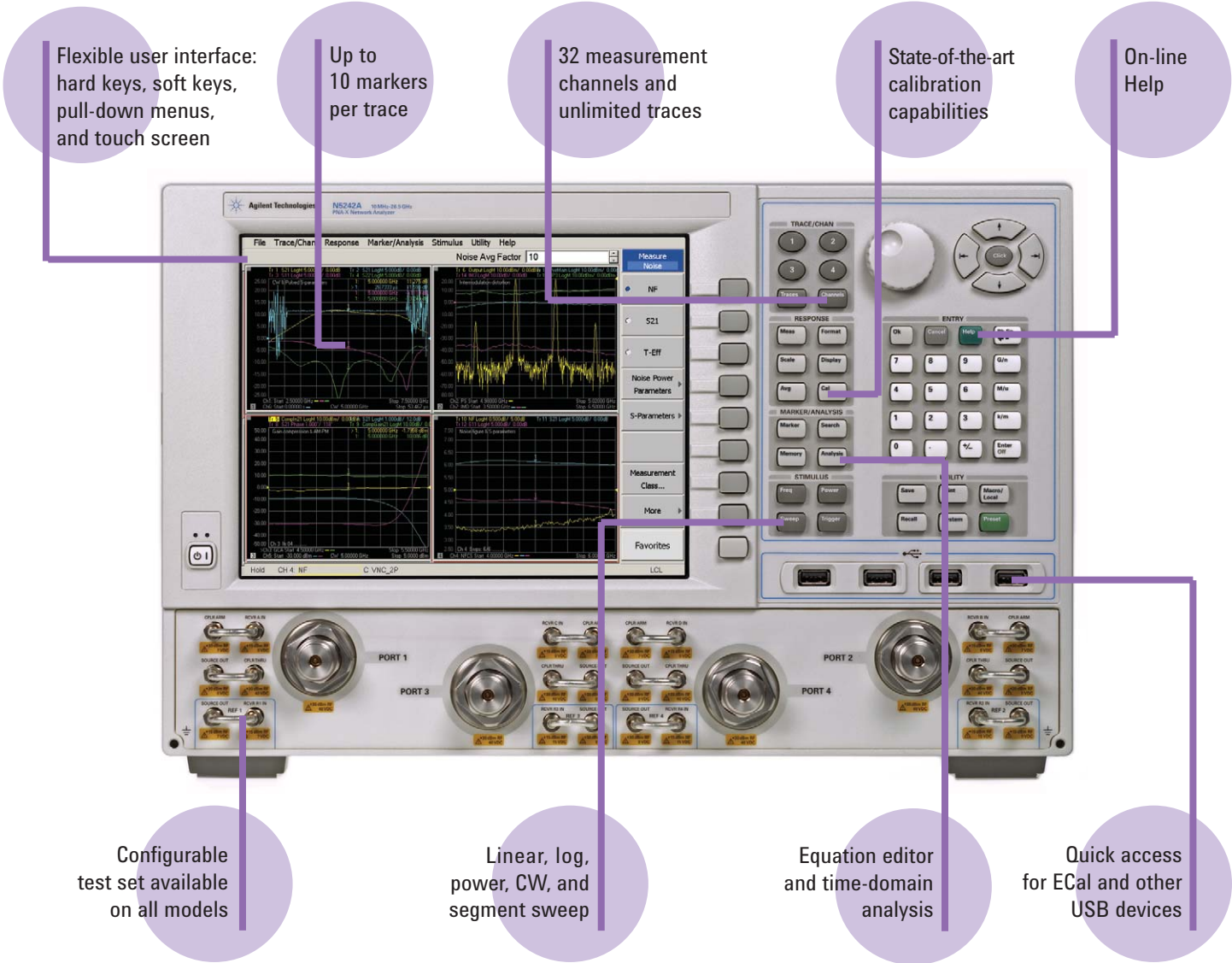


Key features

- ✓ Excellent performance
 - High dynamic range: 127 dB at 20 GHz at test port
 - Low trace noise: 0.002 dB rms at 1 kHz bandwidth
 - Fast measurement speed: 4.5 to 26 μsec/point
 - High stability: 0.05 dB/degrees Celsius
- ✓ State-of-the-art calibration capabilities and wide-range of ECal modules
- ✓ Advanced applications for mixer and pulse measurements
- ✓ Single-ended and balanced measurements
- ✓ 32 measurement channels, unlimited traces, and 32,001 points per channel
- ✓ Connectivity with Open Windows® XP, USB connectors, LAN, and GPIB

Windows is a registered trademark of Microsoft Corporation.

Common features across the PNA family

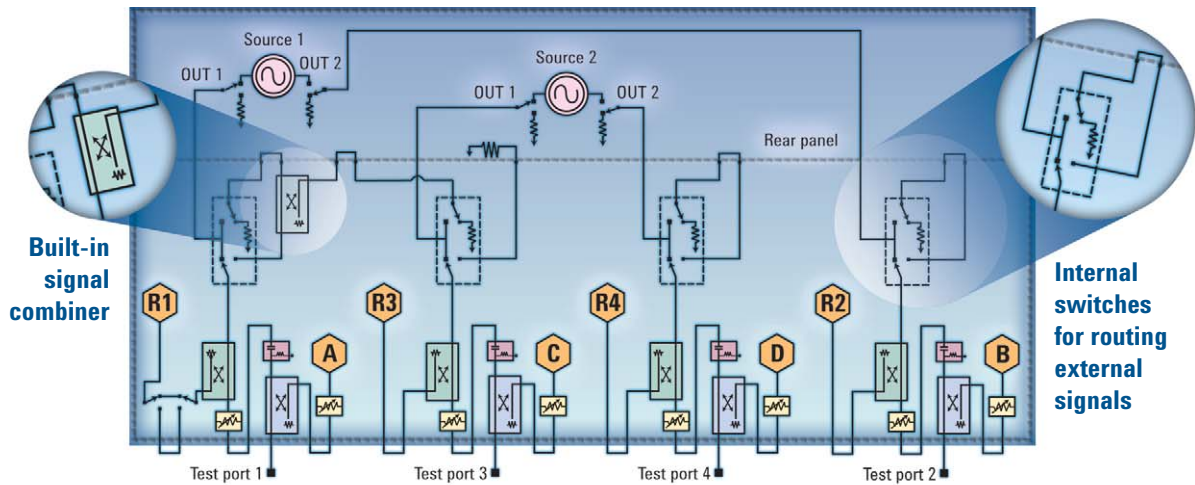


All PNA models integrate a high resolution display with a touch screen, which provides a crisp view and easy access to all data and traces. This enhanced user interface allows intuitive operation and helps you set up complex measurements quickly.



PNA-X – The premier-performance microwave network analyzer

The industry-leading performance and highly integrated configurable nature of the PNA-X make it the ideal solution to address active device measurement challenges. The PNA-X enables engineers to stay on the leading edge of component testing.



PNA-X block diagram (shown with Options 400, 419, and 423).

High quality synthesizers

- ✓ 10 MHz to 13.5, 26.5, 43.5, 50, or 67 GHz
- ✓ Internal 2nd source for IMD, hot- S_{22} , and high speed swept-LO measurements
- ✓ High output power and wide power-sweep range for testing amplifiers
- ✓ Excellent harmonic performance for accurate harmonic and IMD measurements
- ✓ Accurate true-mode stimulus for balanced measurements

Sensitive and linear receivers

- ✓ High compression point for improved dynamic accuracy
- ✓ More sensitivity for pulsed S-parameter measurements

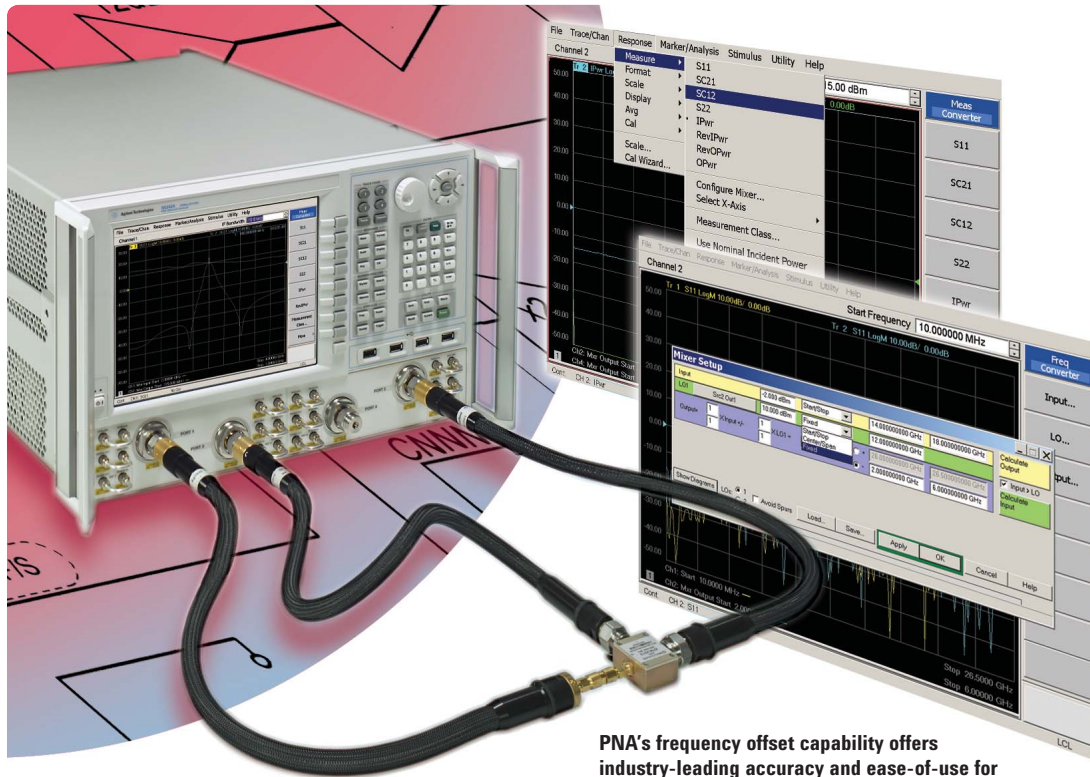
Friendly user interface

- ✓ Large 10.4 inch touch screen display
- ✓ Click-and-drag markers and zoom

Exceptional flexibility

- ✓ Built-in signal combiner for easy IMD and hot- S_{22} measurements
- ✓ Easy pulsed measurements with internal pulse modulators and pulse generators
- ✓ Flexible signal routing via internal switches for adding external filters, pre-amplifiers, and additional test equipment
- ✓ Optional noise figure measurement capability extends the suite of measurements available with a single connection and offers the industry's highest accuracy
- ✓ Front-panel jumpers for direct access to test-port couplers and receivers
- ✓ Source and receiver attenuators for better measurement optimization
- ✓ Built-in bias-tees simplify amplifier evaluation
- ✓ Three sets of triggering lines for complex test systems

PNA-X – Testing beyond the limits – *Mixers and Converters*



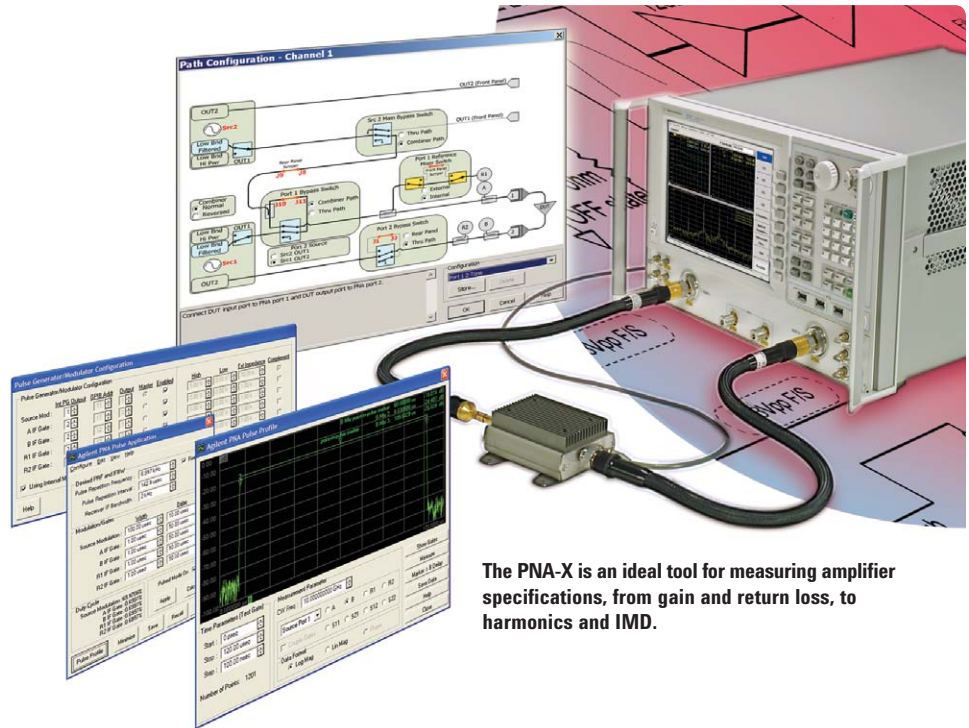
PNA's frequency offset capability offers industry-leading accuracy and ease-of-use for measuring mixers and frequency converters.

Mixer measurements

Checklist

- ✓ Conversion loss/gain, magnitude and phase
- ✓ Input match, output match, and **LO match**
- ✓ Isolation and compression
- ✓ **The two internal independent synthesizers with +13 dBm power and < 60 dBc harmonics eliminate the need for external synthesizers or components.**
- ✓ Advanced error correction
 - **Patented vector-mixer calibration for measurement of absolute group delay**
 - **Scalar-mixer calibration (SMC) for match-corrected amplitude measurements**
- ✓ Significantly faster speed for fixed-IF (20 to 30 times faster than with an external source)
- ✓ Easy-to-configure multi-stage converter measurements
- ✓ LO source control and LO power calibration
- ✓ Fast mixer swept-IMD
- ✓ The simple **two-step** SMC calibration provides **match-corrected conversion loss, error-corrected input and output match**
- ✓ Software tuning for **embedded LO**

PNA-X – Ahead of the curve – Amplifiers, Pulsed-RF



The PNA-X is an ideal tool for measuring amplifier specifications, from gain and return loss, to harmonics and IMD.

Amplifier measurements

Checklist

- ✓ Gain, gain flatness, reverse isolation, and return loss
- ✓ Simple, fast, and accurate AM-AM and AM-PM compression measurements with the **Gain Compression Application** with 38 dB power sweep range at 20 GHz, +13 dBm output power
- ✓ Test harmonics accurately with < 60 dBc source harmonics. **No need for external filters.**
- ✓ Fast **swept-IMD** measurements using two internal sources and a built-in signal combiner. **IMD application** makes set up and calibration fast and simple. Improve test speeds by 100 times compared to spectrum-analyzer-based solutions.
- ✓ Source corrected **noise figure measurements** with exceptional accuracy
- ✓ Integrated source attenuators and receiver attenuators for measurement optimization
- ✓ **Perform all of the above measurements with a single connection using the PNA-X.**

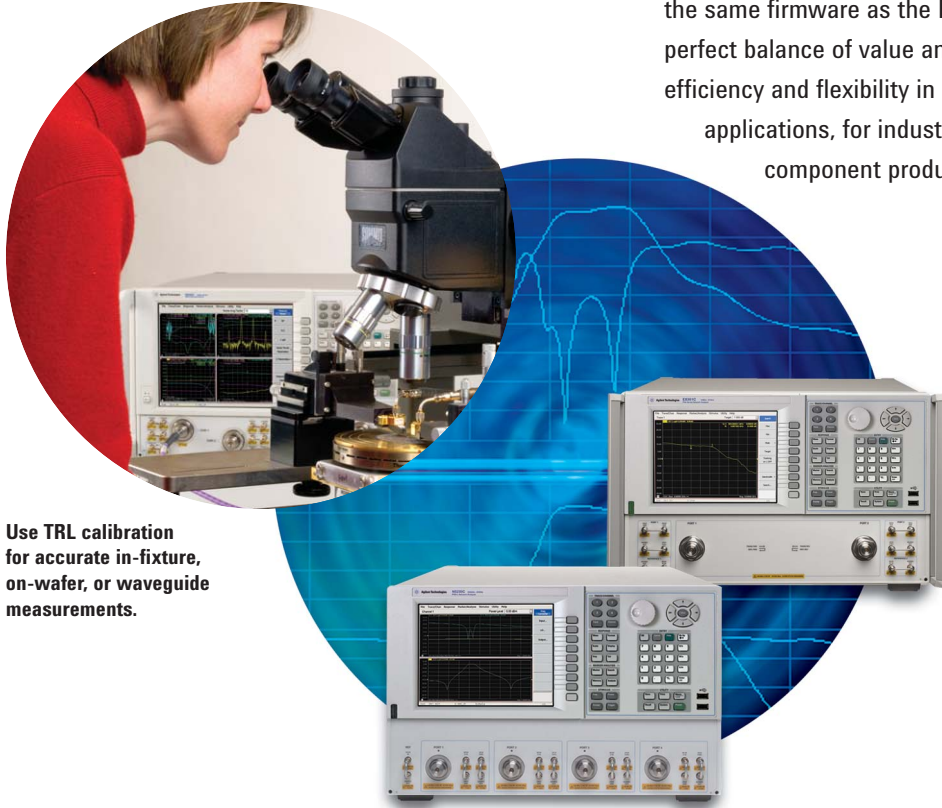
Pulsed-RF measurements

Checklist

- ✓ Wideband and narrowband detection
- ✓ Up to four **internal pulse generators**
- ✓ Up to two **internal pulse modulators**
- ✓ Pulse widths as narrow as 33 ns
- ✓ Point-in-pulse, average pulse, pulse-to-pulse and pulse-profile capability
- ✓ No need for external components

PNA-L – Advanced capability at an affordable price – Passive and active devices, On-wafer test

The Agilent PNA-L is designed for your general-purpose network analysis needs and priced for your budget. With the same firmware as the PNA, the PNA-L offers the perfect balance of value and performance. PNA-L provides efficiency and flexibility in both manufacturing and R&D applications, for industries ranging from wireless LAN component production to aerospace and defense.



Use TRL calibration for accurate in-fixture, on-wafer, or waveguide measurements.

Basic measurements

Checklist

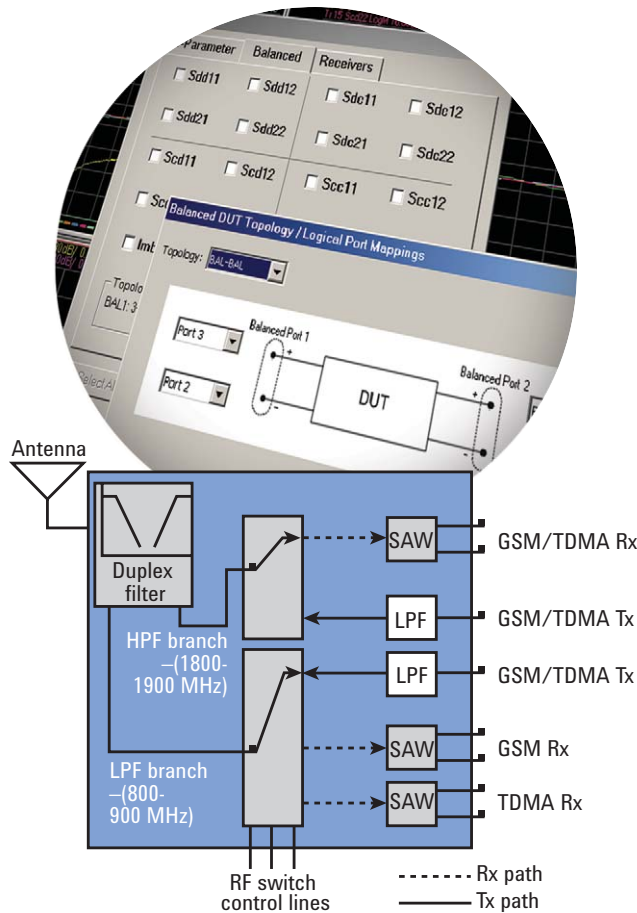
- ✓ Insertion loss, gain, return loss, isolation, group delay, compression, both magnitude and phase
- ✓ Connectorized, in-fixture, or on-wafer
- ✓ Fast and accurate
- ✓ Reliable and repeatable
- ✓ Affordable

On-wafer measurements

Checklist

- ✓ Class of TRL calibrations for accurate measurements
- ✓ Differential measurement capabilities with integrated multiport network analyzers
- ✓ Accurate power control and de-embedding algorithm for device characterization
- ✓ Compatibility with on-wafer calibration software for a total solution

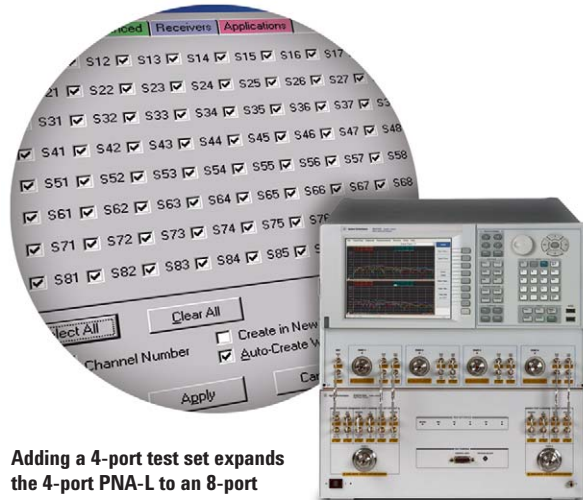
PNA-L – Speed and accuracy you can count on – Balanced/differential measurements and multiport test



Tri-band antenna switch module with balanced and single-ended ports.

Easily measure single-ended, balanced, and mixed-mode S-parameters, in addition to ratioed and unratioed receiver measurements.

New multiport components require complicated test plans. Multiple port combinations must be tested over several frequency bands, resulting in lengthy tests. To reduce test time and lower costs, the PNA-L/PNA-X and test set combinations have been designed for high-speed measurements. To further simplify complex test requirements, up to 32 independent channels are available, eliminating the need for recalling instrument states.



Adding a 4-port test set expands the 4-port PNA-L to an 8-port system with full 8-port measurement capabilities.

Differential measurements

Checklist

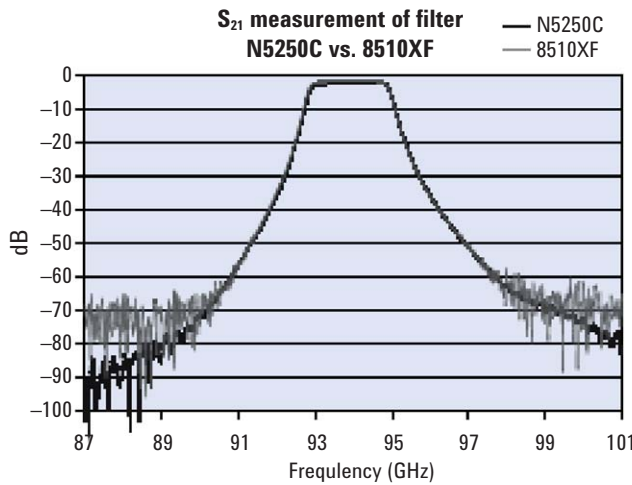
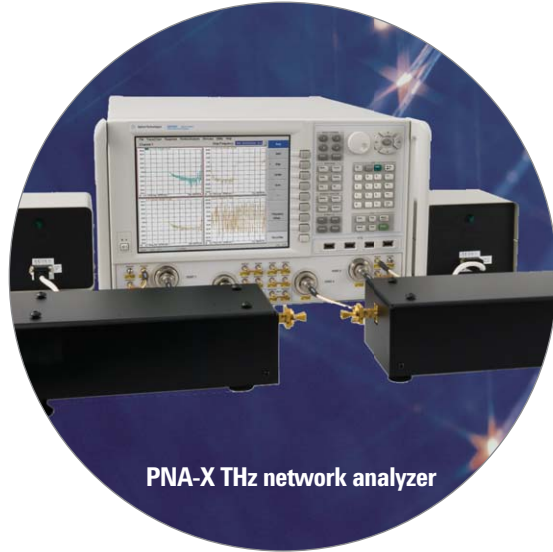
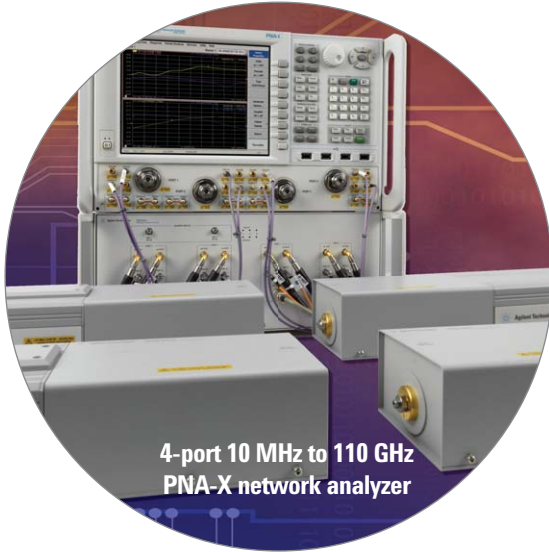
- ✓ Single-ended, balanced, mixed-mode S-parameters
- ✓ Ratioed and unratioed measurements
- ✓ Mode-conversion analysis
- ✓ True-mode stimulus measurements

Multiport measurements

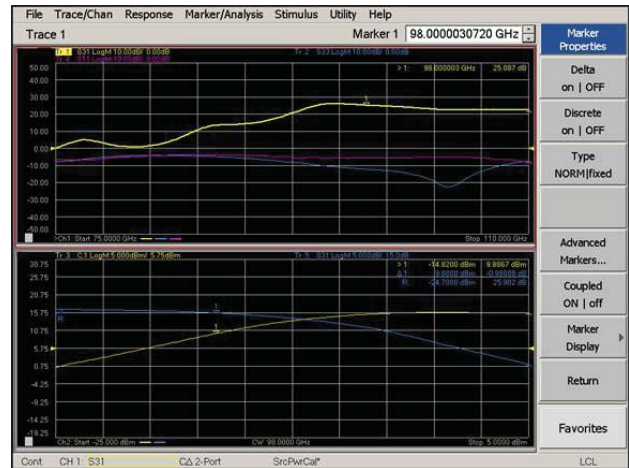
Checklist

- ✓ Multiport configurations optimized for your device, including full cross-bar
- ✓ Quick-Short-Open-Load-Thru (QSOLT) for fast, multiport cal
- ✓ N-port calibration for accuracy and ease-of-measurements
- ✓ Test-set control part of PNA firmware
- ✓ 32 independent channels for fast measurement speed

PNA-X Enabling Terahertz Network Analysis



The N5250C PNA-based mmwave system has superb dynamic range. Shown here is the S₂₁ of a filter at 94 GHz, compared to the 8510XF.



Application of power level control for amplifier gain compression at 98 GHz.

Millimeter-wave network analysis

Checklist

- ✓ Two- and four-port S-Parameter measurements from 10 MHz to 1.05 THz
- ✓ Single-sweep solutions from 10 MHz to 110 GHz with integrated Kelvin bias tee
- ✓ Compact frequency-extender designs for the highest stability measurement system
- ✓ Industry-leading calibration technology for measurements from 10 MHz to 1.05 THz
- ✓ Industry-leading dynamic range without additional external sources on the PNA-X based systems

Millimeter-wave Measurement Applications

Checklist

- ✓ Full power-level control with receiver leveling capability
- ✓ True-mode differential measurements at millimeter-wave frequencies
- ✓ Fully integrated pulsed-RF measurement capability
- ✓ Fully calibrated scalar-mixer measurements capability
- ✓ Industry-leading power sweep capability enabling gain compression measurements
- ✓ Time-domain measurement capability enables high resolution measurements

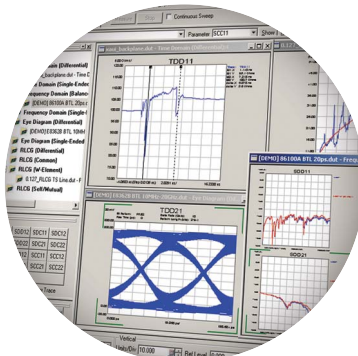
PNA Series simplifies measurements – When the requirements are difficult *Modeling, PLTS, Antenna, Materials test*



High-frequency design and modeling

Checklist

- ✓ PNA drivers included in Connection Manager for easy connectivity
- ✓ Simple downloading of S-parameters into ADS for simulation
- ✓ Save “.s2p, .s4p, snp” files and import into ADS
- ✓ Modeling of devices using IC-CAP and PNA network analyzers



Physical Layer Test Systems (PLTS)

Checklist

- ✓ RLCG model extraction and eye-diagrams
- ✓ High-speed differential interconnect design
- ✓ Multiple aggressor differential crosstalk



Antenna measurements

Checklist

- ✓ 32,001 points per channel
- ✓ Fast measurement speed, 4.5 μ s/pt
- ✓ Forward and reverse sweeps for near-field scans
- ✓ High-sensitivity






Materials measurements

Checklist

- ✓ Measurement of dielectric and magnetic properties
- ✓ Viewing of data in real, imaginary, loss tangent, and Cole-Cole formats
- ✓ Availability of a variety of techniques to meet your materials needs

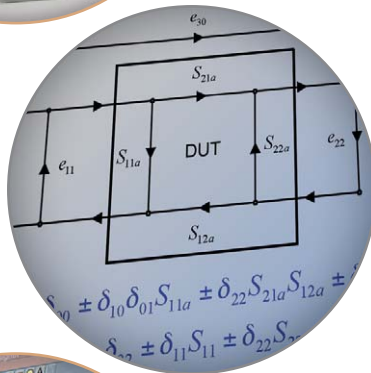
PNA-L/PNA/PNA-X comparison table

Device type	Required measurements	PNA-L	PNA	PNA-X
Mixers				
	Frequency-offset mode	•	•	•
	Conversion loss, isolation, and return loss	•	•	•
	Control of external source for mixer measurements	•	•	•
	Second internal source, used as LO on 2-port analyzer			•
	Second internal source, used as LO on 4-port analyzer	•		•
	Scalar calibrated converter measurements (SMC)	•	•	•
	Vector calibrated converter measurements (VMC)		•	•
	Software tuning for embedded LO		•	•
	+13 dBm output power on 2-ports (for LO)			•
	Compression, AM-PM conversion	•	•	•
Amplifiers				
	Gain, return loss, and reverse isolation	•	•	•
	Power sweep, compression, and AM-PM conversion	•	•	•
	Gain Compression Application			•
	Intermodulation Distortion Application			•
	Maximum output power level	Good	Good	Superb
	Power-sweep range for compression test	Good	Good	Superb
	Receiver compression point	Good	Good	Superb
	Internal bias-tees		•	•
	Source attenuators	• ¹	•	•
	Receiver attenuators		•	•
	Connection loop before reference path ²			•
	Connection loops for attenuators, etc.	•	•	•
	Harmonics measurements	•	•	•
	Analyzer source harmonics	Good	Good	Superb
	Intermodulation distortion	•	•	•
	Second internal source for IMD on 2-port analyzer			•
	Second internal source for IMD on 4-port analyzer	•		•
	Internal combiner for IMD testing			•
	Hot-S ₂₂	Good		Superb
	Noise figure			•
Pulsed-RF				
	Built-in pulse generator and modulators			•
	Wideband detection	Good	•	Superb
	Narrowband detection		Good	Superb
	Pulse-profile	•	•	•
	Point-in-pulse	•	•	•
	Average pulse	•	•	•
	Pulse-to-pulse	•	•	•
Legend				
		•	Solution available	
		Blank	Solution not available	
		Good and superb	Solution available, quality of solution qualified. For example, with maximum output power levels, all PNAs have output power, but the PNA-X has the highest output power.	

1. 4-port PNA-L has one source attenuator. 4-port PNA-X has 4 source attenuators.
2. Applicable to high-power amplifier testing or integration of the external test equipment.

PNA – State-of-the-art calibration capabilities

Calibrating network analyzers is critical for high accuracy measurements and can be particularly challenging in non-coaxial environments such as fixtures, wafers, or waveguides. Additionally, 3- and 4-port devices are more prevalent than ever and require more sophisticated calibration procedures. The need has never been greater for calibration tools that are more accurate and easier to use. The PNA's state-of-the-art calibration techniques help solve these challenges, enhance ease-of-use, and improve accuracy.



Learn how to set up a custom calibration kit with application note 1287-11, *Specifying Calibration Standards and Kits for Agilent Vector Network Analyzers*

High-performance ECal modules

- ✓ High-performance ECal modules, 10 MHz to 26.5 GHz, 10 MHz to 67 GHz and more
- ✓ Nine connector types, mixed-connector modules
- ✓ User characterization for adding adapters

Calibration for non-insertable devices

- ✓ Unknown through calibration
- ✓ QSOLT and n-port calibration (6-port, 8-port, 12-port, etc) for multiport test systems
- ✓ Databased-model and expanded math calibrations for highest accuracy

In-fixture measurements

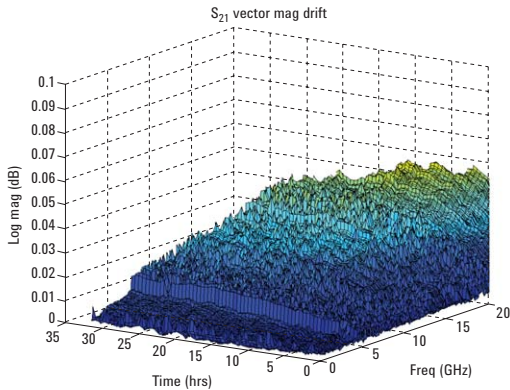
- ✓ Frequency response cal, 1-port cal, 2-port cal, enhanced response-cal, TRL/TRM cal and adapter-removal cal
- ✓ An easy-to-use uncertainty calculator, and a comprehensive application note on calibration standards
- ✓ Automatic port extension removes loss and delay for in-fixture devices

Advanced mixer and amplifier calibrations

- ✓ The patented vector mixer calibration and the popular scalar-mixer calibration
- ✓ De-embedding of attenuators and the new fast source power calibration technique for amplifier measurements
- ✓ De-embedding of probes and waveguides in mixer measurements
- ✓ Unique noise figure calibration removes the effects of imperfect system source match

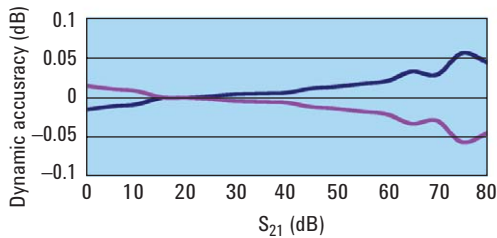
PNA - The standard for accuracy

All the network analyzers in the PNA family are known for their high-levels of stability, contributing to accurate calibrations and measurements. With the PNA-X, users can benefit from exceptional levels of dynamic accuracy. For users in nonlinear environments, the PNA's Scalar Mixer Calibration provides a higher level of measurement accuracy.



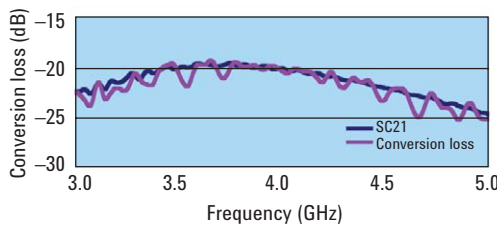
Stability of a 20 GHz PNA over a 30-hour period ¹

It is clear that the more stable the hardware, the better the calibration, since it can correct the errors better. The calibration will remain stable as a function of time and temperature, and calibrations will not need to be updated as often.



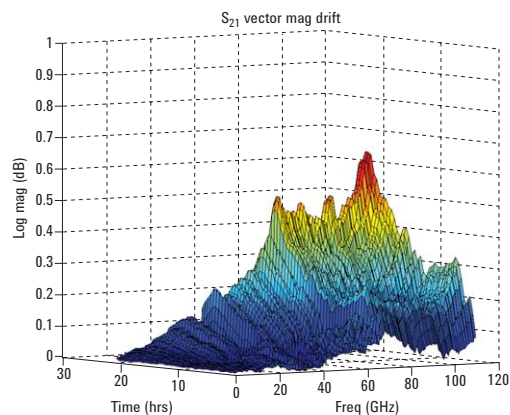
Typical dynamic accuracy of a PNA-X, with -20 dBm power

If you are measuring a device with 20 dB insertion loss, the contribution of the dynamic accuracy error (receiver linearity) is **less than 0.01 dB**.



Scalar-mixer calibration versus a simple power meter/receiver calibration

Note the effects of mismatch that are corrected for by SMC.



110 GHz PNA drift over a 24-hour period ¹

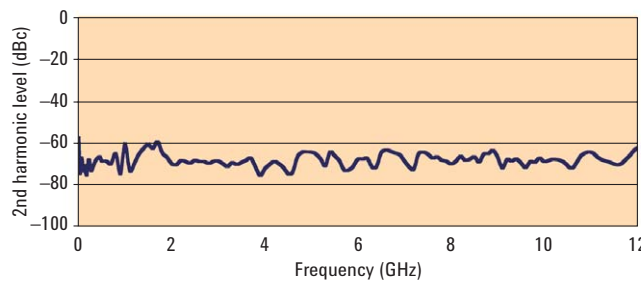
As you can see on the graph, the 110 GHz PNA drifts less than **0.7 dB, after 24 hours, at 110 GHz**. Agilent's 110 GHz PNA system is the most stable mmwave system in the industry.

1. Measurements made at 25 ± 1 degree Celcius.

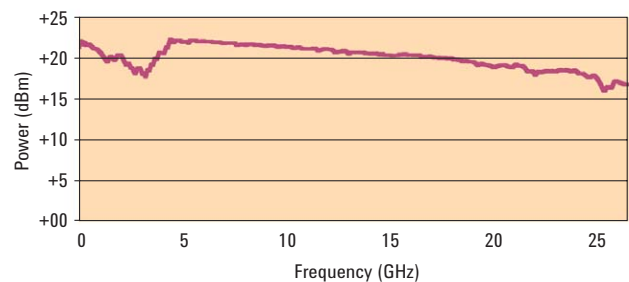
Outstanding performance

Parameter	20 GHz 2-port PNA E8362C	20 GHz 2-port PNA-L N5230C Opt 220	20 GHz 4-port PNA-L N5230C Opt 240	26.5 GHz 2-port PNA-X N5242A Opt 200	26.5 GHz 4-port PNA-X N5242A Opt 400
Frequency range	10 MHz to 20 GHz	10 MHz to 20 GHz	300 kHz to 20 GHz	10 MHz to 26.5 GHz	10 MHz to 26.5 GHz
# of Ports	2	2	4	2	4
Dynamic range ¹	123 dB	108 dB	103 dB	127 dB	127 dB
Noise floor	-120 dBm	-105 dBm	-106 dBm	-114 dBm	-114 dBm
Max output power	+3 dBm	+3 dBm	-3 dBm	+13 dBm	+13 dBm
0.1 dB compression	-5 dBm input	+6 dBm input	+9 dBm input	+12 dBm input	+12 dBm input
Trace noise	0.006 dB rms 1 kHz IFBW 0 dBm	0.006 dB rms 1 kHz IFBW -5 dBm	0.010 dB rms 100 kHz IFBW -5 dBm	0.005 dB rms 100 kHz IFBW -5 dBm	0.005 dB rms 100 kHz IFBW -5 dBm
ALC range	27 dB	23 dB	22 dB	38 dB	38 dB
Max IFBW	40 kHz	250 kHz	600 kHz	5 MHz	5 MHz
Speed	26 μ s/pt	9 μ s/pt	4.5 μ s/pt	4.5 μ s/pt	4.5 μ s/pt
Display size, LCD	21.3 cm	21.3 cm	21.3 cm	26.4 cm	26.4 cm
Touch screen	Yes	Yes	Yes	Yes	Yes

Parameter	40 GHz PNA-L N5230C Option 420	40 GHz PNA E8363C	43.5 GHz PNA-X N5244A Option 200
Frequency range	10 MHz to 40 GHz	10 MHz to 40 GHz	10 MHz to 43.5 GHz
Dynamic range	90 dB	110 dB	119 dB
Noise floor	-95 dBm	-114 dBm	-110 dBm
Max output power	-5 dBm	-4 dBm	+9 dBm
0.1 dB compression	-8.5 dBm	-12.5 dBm	+13 dBm
Trace noise (1 kHz)	0.020 dB rms	0.006 dB rms	0.003 dBms
ALC range	20 dB	20 dB	34 dB
Max IFBW	250 kHz	40 kHz	5 MHz
Speed	9 μ s/pt	26 μ s/pt	4.5 μ s/pt



N5242A Typical PNA-X source harmonics



N5242A Typical PNA-X output power

1. 20 GHz, test port, 10 Hz IFBW.

Completing the solution



Protect confidential data

The best method for maintaining security is to remove the hard disk drive. The PNA provides the removable hard disk drive as a standard feature, enabling you to easily remove the drive and keep it safe in a secure area.

Protect your software investment

Agilent protects your 8753, 8720 and 8510 software investment by providing migration tools to reduce your code conversion effort.

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Visit the online network analyzer discussion forum where you can learn how your peers are solving some of their most challenging measurement problems.

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